

STF26N60M2, STFI26N60M2

N-channel 600 V, 0.14 Ω typ., 20 A MDmesh™ M2 Power MOSFETs in TO-220FP and I²PAKFP packages

Datasheet - production data

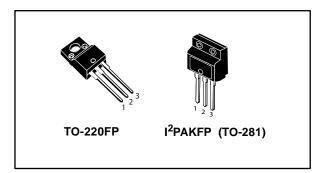
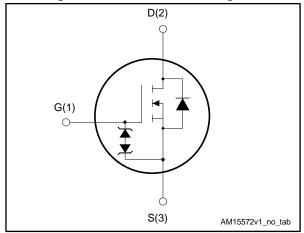


Figure 1: Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max.	I _D	Ртот
STF26N60M2	650 V	0.165 Ω	20 A	30
STFI26N60M2	650 V	0.165 12	20 A	W

- Extremely low gate charge
- Excellent output capacitance (C_{OSS}) profile
- 100% avalanche tested
- Zener-protected

Applications

- Switching applications
- LCC converters, resonant converters

Description

These devices are N-channel Power MOSFETs developed using MDmesh™ M2 technology. Thanks to their strip layout and improved vertical structure, these devices exhibit low on-resistance and optimized switching characteristics, rendering them suitable for the most demanding high efficiency converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STF26N60M2	OCNICOMO	TO-220FP	Tubo
STFI26N60M2	26N60M2	I ² PAKFP	Tube

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{GS}	Gate-source voltage	±25	V
I _D ⁽¹⁾	Drain current (continuous) at T _{case} = 25 °C	20	Α
ID	Drain current (continuous) at T _{case} = 100 °C	13	А
I _{DM} ⁽²⁾	Drain current (pulsed)	80	Α
P _{TOT}	Total dissipation at T _{case} = 25 °C	30	W
dv/dt ⁽³⁾	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	V/IIS
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; T_C = 25 °C)	2.5	kV
T _{stg}	Storage temperature	55 to 150	°C
T _j	Operating junction temperature	-55 to 150	C

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit	
R _{thj-case}	Thermal resistance junction-case	4.2	0000	
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W	

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR} ⁽¹⁾	Avalanche current, repetitive or not repetitive	3.8	Α
E _{AR} ⁽²⁾	Single pulse avalanche energy	250	mJ

Notes:

⁽¹⁾ Limited by maximum junction temperature.

 $^{^{\}left(2\right) }$ Pulse width is limited by safe operating area.

 $^{^{(3)}}$ $I_{SD} \leq 20$ A, di/dt=400 A/µs; $V_{DS(peak)} < V_{(BR)DSS}, \ V_{DD} = 80\% \ V_{(BR)DSS}.$

 $^{^{(4)}} V_{DS} \le 480 V.$

 $^{^{\}left(1\right)}$ Pulse width limited by $T_{jmax}.$

 $^{^{(2)}}$ starting T_{j} = 25 °C, I_{D} = $I_{AR},\,V_{DD}$ = 50 V.

2 Electrical characteristics

(T_{case} = 25 °C unless otherwise specified)

Table 5: Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	600			٧
Zara sata walta na dunin		$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V}$			1	
I _{DSS}	I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 600 \text{ V},$ $T_{case} = 125 \text{ °C}$			100	μΑ
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 10 A		0.14	0.165	Ω

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1360	ı	
Coss	Output capacitance	$V_{DS} = 100 \text{ V}, f = 1 \text{ MHz},$	-	88	•	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0 V$	-	2	-	ρ,
Coss eq. (1)	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	124	1	pF
R_{G}	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	4	-	Ω
Q_g	Total gate charge	$V_{DD} = 480 \text{ V}, I_{D} = 20 \text{ A},$	-	34	ı	
Q_gs	Gate-source charge	V _{GS} = 10 V (see <i>Figure 15</i> :	-	5.6		nC
Q_{gd}	Gate-drain charge	"Gate charge test circuit")	-	16.3	•	

Notes:

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 300 \text{ V}, I_D = 10 \text{ A}$	-	20.2	-	
t _r	Rise time	$R_G = 4.7 \Omega$, $V_{GS} = 10 V$ (see Figure 14: "Switching times	-	8	-	
t _{d(off)}	Turn-off delay time	test circuit for resistive load"	-	66	-	ns
t _f	Fall time	and Figure 19: "Switching time waveform")	-	10	-	



 $^{^{(1)}}$ $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		20	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		80	Α
V _{SD} ⁽²⁾	Forward on voltage	V _{GS} = 0 V, I _{SD} = 20 A	-		1.6	V
t _{rr}	Reverse recovery time	$I_{SD} = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	360		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load	-	5		μC
I _{RRM}	Reverse recovery current	switching and diode recovery times")	ı	27		Α
t _{rr}	Reverse recovery time	$I_{SD} = 20 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s},$	-	556		ns
Q _{rr}	Reverse recovery charge	V_{DD} = 60 V, T_j = 150 °C (see Figure 16: "Test circuit for	-	8		μC
I _{RRM}	Reverse recovery current	inductive load switching and diode recovery times")	-	29		Α

Notes:

 $^{^{\}left(1\right) }$ Pulse width is limited by safe operating area.

 $^{^{(2)}}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

2.1 Electrical characteristics (curves)

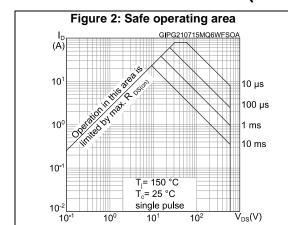


Figure 3: Thermal impedance occoss 1 $\delta = 0.5$ 0.2 0.0.1 0.02 0.05 0.0

Figure 4: Output characteristics

GIPG210715MG6WPOCH

(A)

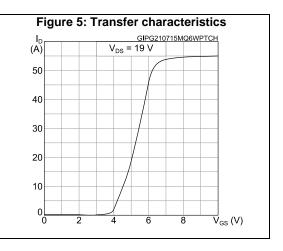
V_{GS} = 7,8,9,10 V

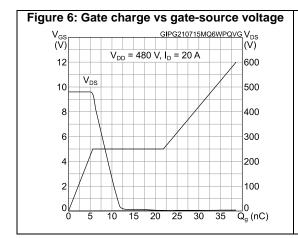
V_{GS} = 6 V

V_{GS} = 5 V

V_{GS} = 4 V

0 4 8 12 16 V_{DS} (V)





6/15

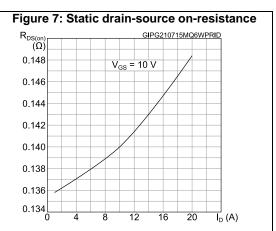


Figure 8: Capacitance variations

C GPF)

103

104

Coss

105

106

107

108

CRSS

109

109

1001

1001

1001

1001

1001

1001

1002

CRSS

(V)

Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG210715MQ6WPRON
(norm.)

2.4

2.0

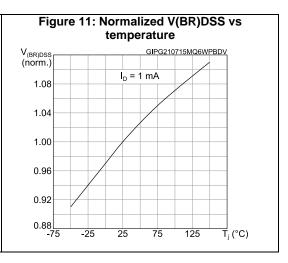
1.6

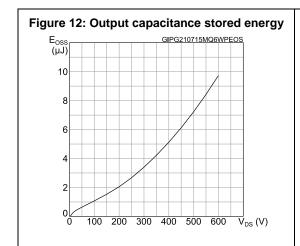
1.2

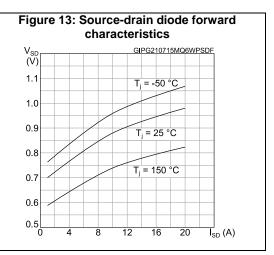
0.8

0.4

-75
-25
25
75
125
T_j (°C)



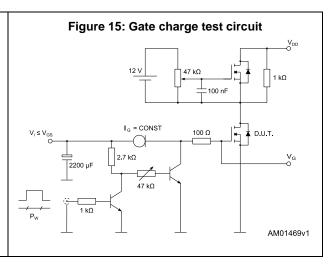


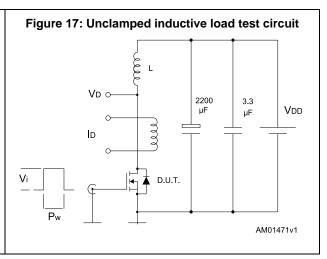


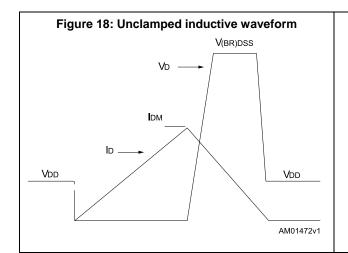
3 Test circuits

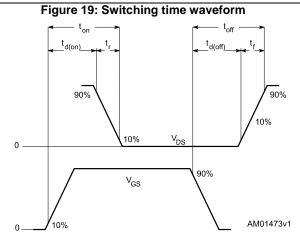
Figure 14: Switching times test circuit for resistive load

AM01468v1









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4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-220FP package information

Figure 20: TO-220FP package outline

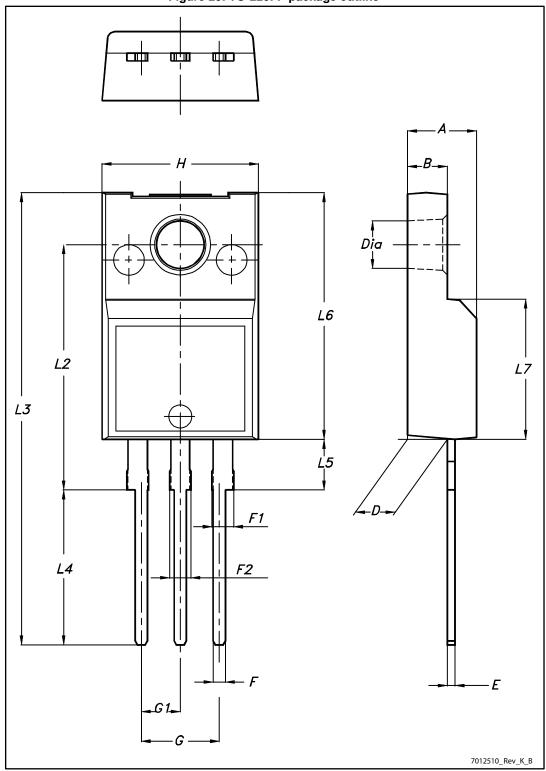


Table 9: TO-220FP package mechanical data

	lable of the 22011 par	mm	
Dim.			
	Min.	Тур.	Max.
Α	4.4		4.6
В	2.5		2.7
D	2.5		2.75
Е	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2

4.2 I²PAKFP (TO-281) package information

Figure 21: I²PAKFP (TO-281) package outline

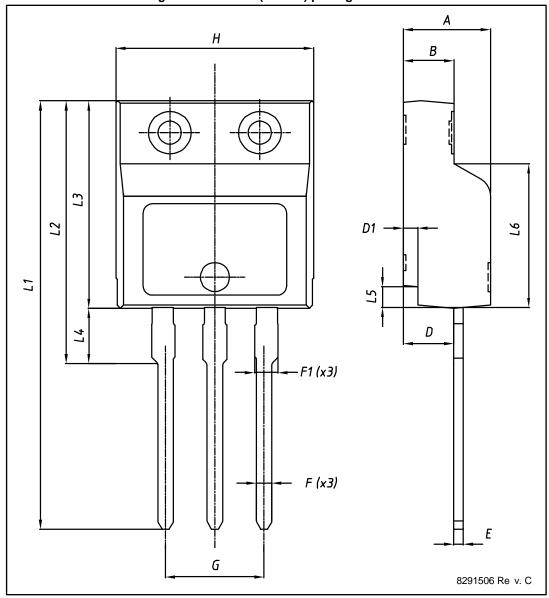


Table 10: I²PAKFP (TO-281) mechanical data

Dim	,	mm	
Dim.	Min.	Тур.	Max.
A	4.40	-	4.60
В	2.50		2.70
D	2.50		2.75
D1	0.65		0.85
E	0.45		0.70
F	0.75		1.00
F1			1.20
G	4.95		5.20
Н	10.00		10.40
L1	21.00		23.00
L2	13.20		14.10
L3	10.55		10.85
L4	2.70		3.20
L5	0.85		1.25
L6	7.50	7.60	7.70

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
05-Mar-2015	1	First release.
30-July-2015	2	Text and formatting changes throughout document Datasheet promoted from preliminary data to production data In Section <i>Electrical characteristics</i> : - updated and renamed table <i>Static</i> (was On/off states) - updated table <i>Dynamic</i> , <i>Switching times</i> and <i>Source-drain diode</i> - added section <i>Electrical characteristics</i> (curves)

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